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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIDMATIONALO
10/081,992	02/21/2002	Been-Yih Jin	10559-587001 / P12768	CONFIRMATION NO.
•	7590 05/19/2004		EXAMINER	
FISH & RICHARDSON, PC 12390 EL CAMINO REAL			POMPEY, RON EVERETT	
SAN DIEGO,	CA 92130-2081		ART UNIT	PAPER NUMBER
			2812	
			DATE MAILED: 05/19/2004	· 

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)	
-	Office Action Summary	10/081,992	JIN ET AL.	
	Office Action Summary	Examiner	Art Unit	<del></del>
		Ron E Pompey	2812	
	The MAILING DATE of this communication ap	pears on the cover sheet w	ith the correspondence a	ddress
	A SHORTENED STATUTORY PERIOD FOR REPL THE MAILING DATE OF THIS COMMUNICATION.  Extensions of time may be available under the provisions of 37 CFR 1. after SIX (6) MONTHS from the mailing date of this communication.  If the period for reply specified above is less than thirty (30) days, a repl If NO period for reply sis specified above, the maximum statutory period.  Failure to reply within the set of content of the state of the st	Y IS SET TO EXPIRE 3 M 136(a). In no event, however, may a r ly within the statutory minimum of thir will apply and will expire SIX (6) MON	IONTH(S) FROM reply be timely filed by (30) days will be considered time ITHS from the mailing date of this control.	
· ·	earned patent term adjustment. See 37 CFR 1.704(b).	g date of this communication, even if	timely filed, may reduce any	
	Status			
	1) Responsive to communication(s) filed on <u>01 M</u>	larch 2004	***	
	2a)⊠ This action is FINAL. 2b)☐ This	action is non-final		
	3) Since this application is in condition for allower	nce except for formal matte	ers prospoution on to the	
	closed in accordance with the practice under E	Ex parte Quavle 1935 C.D.	11 453 O C 212	ments is
	Disposition of Claims			***
٠.			•	
	4)⊠ Claim(s) <u>8-21</u> is/are pending in the application.			4 0
	4a) Of the above claim(s) is/are withdray	vn from consideration.		
	5) Claim(s) is/are allowed.		•	
	6)⊠ Claim(s) <u>8-21</u> is/are rejected.		* *	
- 1	7)☐ Claim(s) is/are objected to.	× <b>a</b>		
	8) Claim(s) are subject to restriction and/or	election requirement		
•		ore strong an emont.		
·	Application Papers			• • • • • • • • • • • • • • • • • • • •
	9) The specification is objected to by the Examiner			, i
٠	10) The drawing(s) filed on is/are: a) acce	nted or h\□ objected to be		
	Applicant may not request that any objection to the d	rowing(s) he held in a	y the Examiner.	<u> </u>
	Replacement drawing sheet(s) including the correction	rawing(s) be neid in abeyanc	e. See 37 CFR 1.85(a).	
٠.	Replacement drawing sheet(s) including the correction	on is required if the drawing(s	) is objected to. See 37 CF	R 1.121(d).
	11) ☐ The oath or declaration is objected to by the Exa	iminer. Note the attached (	Office Action or form PT	D-152.
1	Priority under 35 U.S.C. § 119		φ.	9.0
	12) Acknowledgment is made of a claim for foreign p	oriority under 35 U.S.C. § 1	19(a)-(d) or (f).	•
.	a) ☐ All b) ☐ Some * c) ☐ None of:	• • •		
	1. Certified copies of the priority documents	have been received.	*	
1	2. Certified copies of the priority documents	have been received in Apr	olication No.	
	Copies of the certified copies of the priority	y documents have been re	ceived in this National S	tane
$\perp$	application from the international Bureau (	(PCT Rulė 17 2(a))	,	iago ,
	* See the attached detailed Office action for a list of	the certified copies not re	ceived	
			oorvou.	
	*			
1	Attachment(s)	*		-
1	Notice of References Cited (PTO-892)	Λ. C	• •	
2	P) U Notice of Draftsperson's Patent Drawing Review (PTO-948)	4) 🔲 Interview Sum Paper No(s)/M	mary (PTO-413) Iail Date	
	Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date	5) Notice of Infor 6) Other:	mal Patent Application (PTO-1	52)
U.S	Patent and Trademark Office OL-326 (Rev. 1-04) Office Actio			
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#### **DETAILED ACTION**

## Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 1. Claims 8-21 are rejected under 35 U.S.C. 103(a) as being unpatentable over Chen et al. (US 5,545, 574) in further view of Yu (US 6,100,120) and Eguchi (US 5,185,286).

Chen discloses the limitations of:

a semiconductor substrate, the substrate being substantially free of silicon (20, fig. 2);

a gate dielectric layer (24, fig. 2) formed over a portion of the substrate; and a gate electrode, source and drain regions (26, 32 and 34, fig. 4) further comprising (col. 2, ln. 54 – col. 3, ln. 14): an interlayer dielectric layer (92, fig. 9) over the gate, source and drain (col. 4, lns. 31-35). Chen does not explicitly describe that the well and source and drain are different type of dopants, however it is inherent and well know that if you have an n-type of transistor that the well and source and drain regions are of different type dopants. Chen does disclose that the device formed is an n-channel device (col. 5, ln. 2).

Chen discloses the limitations of the claimed invention except, wherein the gate dielectric comprises a material having a dielectric constant greater than about 10

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wherein the thickness is large enough to prevent a portion of off-state leakage and the interlevel dielectric defines first, second and third openings in the interlayer dielectric layer and further comprising: a metal within the first, second and third openings in contact with gate electrode, source and drain regions.

However, Yu discloses the limitations of forming a gate dielectric with a dielectric constant greater than about 10 (col. 4, Ins. 28-31; 22, fig. 4). Yu shows that it is well—known in the art to use high dielectric constant materials for gate dielectrics therefore the physical thickness of the gate dielectric has less direct tunnel leakage.

Also, Eguchi discloses the limitations of forming contacts to the device (col. 4, Ins. 30-36; 11, 12, 13 and 14, fig. 3). Therefore it would have been obvious to one of ordinary skill in the art to combine Eguchi with Chen, because the contacts allow for electrical communication to the MOS device from external devices.

### Response to Arguments

2. Applicant's arguments filed 3-1-04, pertaining to claims 8-21, have been fully considered but they are not persuasive. The applicant argues that Yu does not disclose or suggest use of a high-k insulator formed on a substrate that is substantially free of silicon. However, Chen discloses that the "Substrate is any of a variety of semiconductor materials" (see column 3, lines 21-22). Therefore one of ordinary skill in the art would use any semiconductor material that is known to the industry, which includes ones that are substantially free of silicon, to form a substrate.

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### Conclusion

3. **THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not-mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Ron E Pompey whose telephone number is (571) 272-1680. The examiner can normally be reached on flex schedule.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Niebling can be reached on (571) 272-1679. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic—Business Center (EBC) at 866-217-9197 (toll-free).

Ron Pompey AU: 2812 May 17, 2004

Supervisory Patent Examiner Technology Center 2800